


Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/678,714	MIHAI ET AL.	
	Examiner	Art Unit	
	Emeka Ebirim	2166	

SEARCHED			
Class	Subclass	Date	Examiner
707	1-10	3/8/2006	EE

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST	3/8/2006	EE
NPL (Google, ACM)	3/8/2006	EE
Consulted Pham Khanh (primary)	3/9/2006	EE
Consulted Alam Hosain (SPE)	3/9/2006	EE